

Notice of References Cited	Application/Control No. 10/661,596	Applicant(s)/Patent Under Reexamination KUNO, OJI	
	Examiner Cam N. Nguyen	Art Unit 1754	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,956,008	10-2005	Takeshima et al.	502/326
	B	US-6,139,814	10-2000	Shigapov et al.	423/592.1
	C	US-5,837,642	11-1998	Tanaka et al.	502/304
	D	US-6,261,989	07-2001	Tanaka et al.	502/217
	E	US-6,585,944	07-2003	Nunan et al.	423/239.1
	F	US-6,682,706	01-2004	Yamamoto et al.	422/180
	G	US-6,528,451	03-2003	Brezny et al.	502/304
	H	US-6,228,799	05-2001	Aubert et al.	502/304
	I	US-6,171,572	01-2001	Aozasa, Shigeru	423/594.12
	J	US-6,326,329	12-2001	Nunan, John G.	502/242
	K	US-6,339,037	01-2002	Kase et al.	502/300
	L	US-6,831,036	12-2004	Yamazaki et al.	502/327
	M	US-5,945,369	08-1999	Kimura et al.	502/304

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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